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Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,317	MCKEAN ET AL.
Examiner	Art Unit
Tianjie Chen	2652

SEARCHED				
Class	Subclass	Date	Examiner	
360	235.1			
	234			
29	603.12	·		
216	22			
427	475			
428	189			
523	201			
	513	7/6/2005	TJ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Reports	7/6/2005	ΤJ		
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